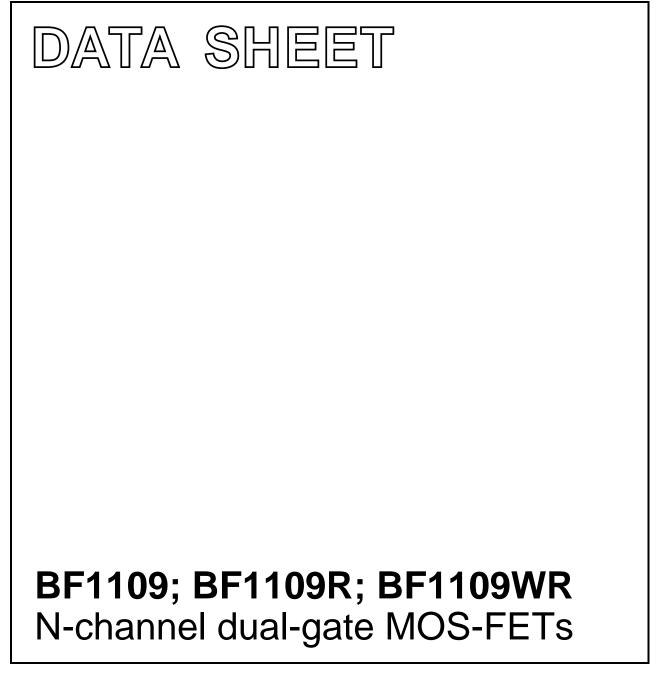
DISCRETE SEMICONDUCTORS



Product specification Supersedes data of 1997 Sep 03



BF1109WR

N-channel dual-gate MOS-FETs

FEATURES

PINNING

PIN

1

2

3

4

DESCRIPTION

source

drain

gate 2

gate 1

- Short channel transistor with high forward transfer admittance to input capacitance ratio
- Low noise gain controlled amplifier up to 1 GHz
- Internal self-biasing circuit to ensure good cross-modulation performance during AGC and good DC stabilization.

APPLICATIONS

 VHF and UHF applications with 9 V supply voltage, such as television tuners and professional communications equipment.

DESCRIPTION

Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1109, BF1109R and BF1109WR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.

QUICK REFERENCE DATA

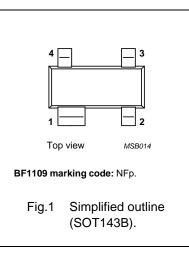
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage		_	-	11	V
I _D	drain current (DC)		_	-	30	mA
P _{tot}	total power dissipation	$T_{amb} \le 80 \ ^{\circ}C$	_	-	200	mW
y _{fs}	forward transfer admittance		_	30	-	mS
C _{ig1-ss}	input capacitance at gate 1		_	2.2	2.7	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	25	40	fF
F	noise figure	f = 800 MHz	_	1.5	2.5	dB
X _{mod}	cross-modulation	input level for k = 1% at 40 dB AGC	100	-	-	dBµV
Tj	operating junction temperature		-	-	150	°C

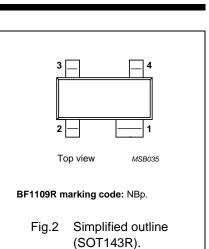
CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.

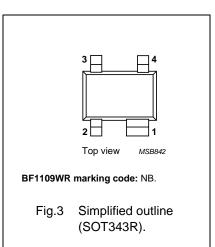
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BF1109; BF1109R;



BF1109; BF1109R; BF1109WR

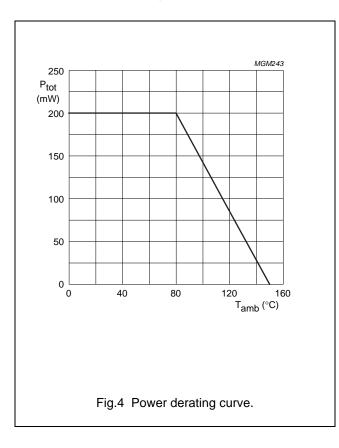
LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	11	V
I _D	drain current (DC)		_	30	mA
I _{G1}	gate 1 current		_	±10	mA
I _{G2}	gate 2 current		_	±10	mA
P _{tot}	total power dissipation	$T_{amb} \le 80 \ ^{\circ}C$; note 1	_	200	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	operating junction temperature		_	+150	°C

Note

1. Device mounted on a printed-circuit board.



BF1109; BF1109R; BF1109WR

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient in free air	note 1	350	K/W
R _{th j-s}	thermal resistance from junction to soldering point		200	K/W

Note

1. Device mounted on a printed-circuit board.

STATIC CHARACTERISTICS

 $T_j = 25 \ ^{\circ}C$ unless otherwise specified.

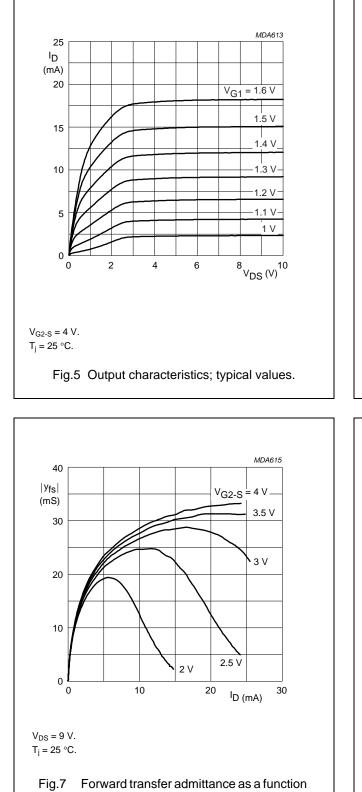
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{(BR)DSS}	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0; I_D = 10 \ \mu A$	11	-	V
V _{(BR)G1-SS}	gate 1-source breakdown voltage	$V_{G2-S} = 0; I_{G1-S} = 10 \ \mu A; I_D = 0$	11	-	V
V _{(BR)G2-SS}	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0; I_{G2-S} = 10 \ \mu A$	11	-	V
V _{G2-S (th)}	gate 2-source threshold voltage	$V_{G1-S} = 9 V; V_{DS} = 9 V; I_D = 20 \ \mu A$	0.3	1.2	V
I _{DSX}	self-biasing drain current	V _{G2-S} = 4 V; V _{DS} = 9 V	8	16	mA
I _{G1-SS}	gate 1 cut-off current	$V_{G1-S} = 9 V; V_{G2-S} = 0; I_D = 0$	-	20	nA
I _{G2-SS}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0; V_{G2-S} = 9 V$	-	20	nA

DYNAMIC CHARACTERISTICS

Common source; T_{amb} = 25 °C; V_{G2-S} = 4 V; V_{DS} = 9 V; self-biasing current; unless otherwise specified.

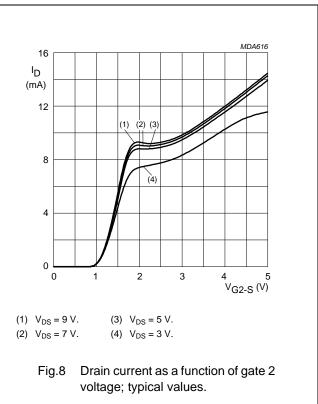
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
y _{fs}	forward transfer admittance	pulsed; T _j = 25 °C	24	30	-	mS
C _{ig1-ss}	input capacitance at gate 1	f = 1 MHz	-	2.2	2.7	pF
C _{ig2-ss}	input capacitance at gate 2	f = 1 MHz	_	1.5	_	pF
C _{oss}	output capacitance	f = 1 MHz	-	1.3	-	pF
C _{rss}	reverse transfer capacitance	f = 1 MHz	-	25	40	fF
F	noise figure	$f = 800 \text{ MHz}; Y_S = Y_S \text{ opt}$	-	1.5	2.5	dB
G _p	power gain	$G_{S} = 2 \text{ mS}; B_{S} = B_{S \text{ opt}}; G_{L} = 0.5 \text{ mS};$ $B_{L} = B_{L \text{ opt}}; f = 200 \text{ MHz}; \text{ see Fig.16}$	-	38	_	dB
		$G_{S} = 3.3 \text{ mS}; B_{S} = B_{S \text{ opt}}; G_{L} = 1 \text{ mS};$ $B_{L} = B_{L \text{ opt}}; f = 800 \text{ MHz}; \text{ see Fig.17}$	-	20	_	dB
X _{mod}	cross-modulation	input level for k = 1% at 0 dB AGC; f _w = 50 MHz; f _{unw} = 60 MHz; see Fig.18	85	-	-	dBμV
		input level for k = 1% at 40 dB AGC; $f_w = 50 \text{ MHz}$; $f_{unw} = 60 \text{ MHz}$; see Fig.18	100	-	-	dBμV

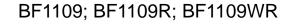
BF1109; BF1109R; BF1109WR

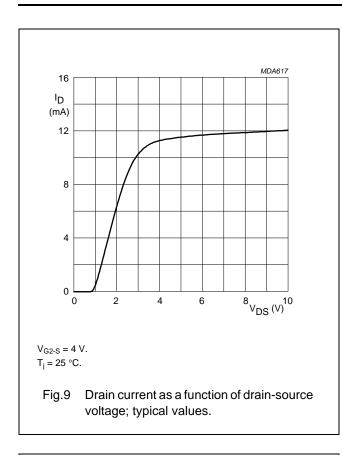


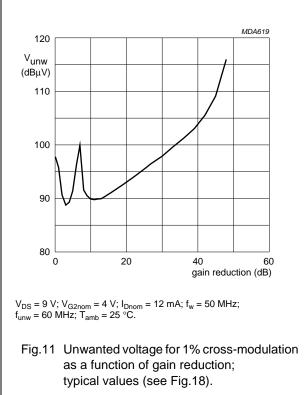
of drain current; typical values.

MDA614 40 ΙD (mA) 30 V_{G2-S} = 4 V 3.5 V 3 V 20 2.5 2 V 10 1.5 \ 1 V 0 0.5 0 1.5 2 1 2.5 $V_{G1}(V)$ $V_{DS} = 9 V.$ T_j = 25 °C. Fig.6 Transfer characteristics; typical values.









1997 Dec 08

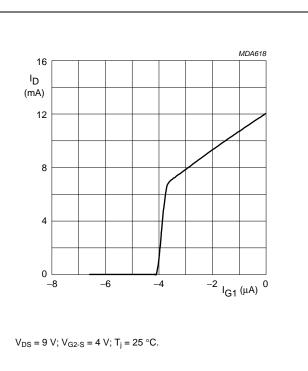
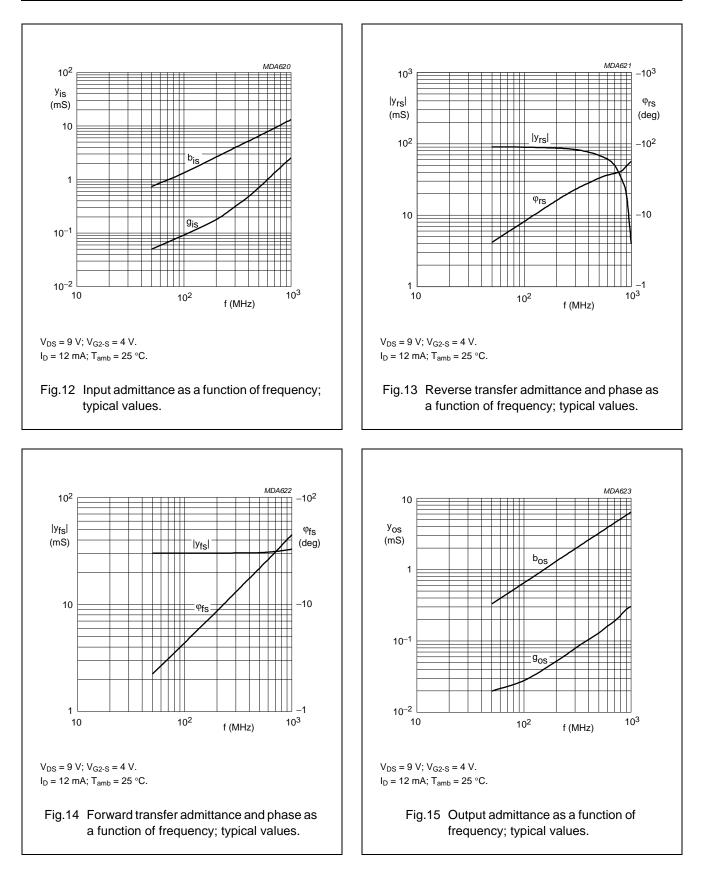


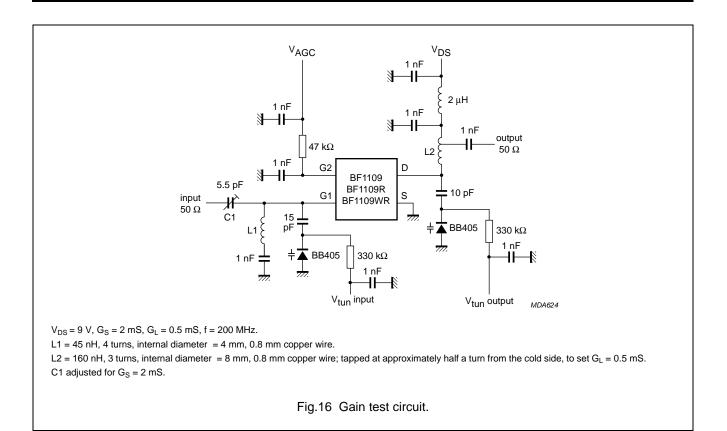
Fig.10 Drain current as a function of gate 1 current; typical values.

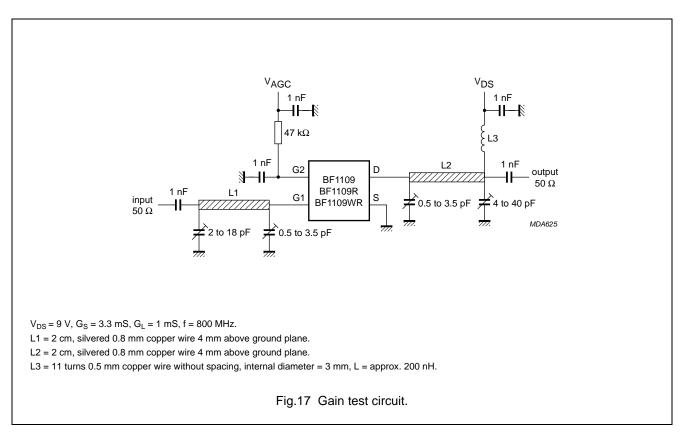
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BF1109; BF1109R; BF1109WR





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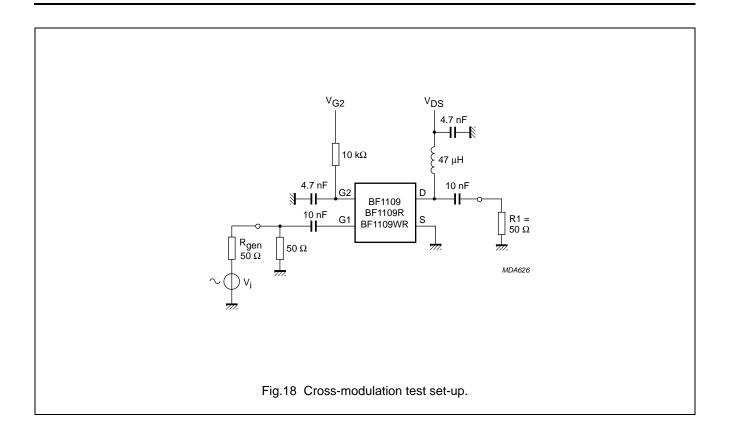


Table 1Scattering parameters: $V_{DS} = 9 V$; $V_{G2-S} = 4 V$; $I_D = 12 mA$

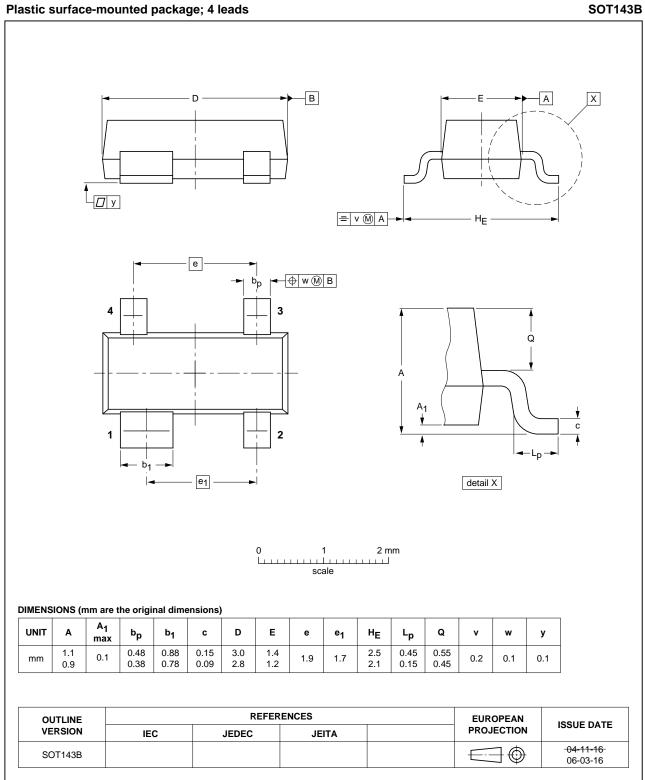
f	S ₁₁		S ₂₁		S ₁₂		S ₂₂	
(MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)
50	0.995	-3.71	3.013	175.0	0.000	88.2	0.998	-1.8
100	0.992	-7.29	3.002	170.2	0.001	83.7	0.997	-3.5
200	0.984	-14.3	2.967	160.7	0.002	86.2	0.995	-7.0
300	0.973	-21.2	2.922	151.3	0.002	83.2	0.992	-10.5
400	0.961	-27.9	2.869	142.0	0.003	84.1	0.990	-13.9
500	0.944	-34.4	2.793	132.9	0.003	85.7	0.987	-17.2
600	0.926	-40.8	2.730	124.1	0.003	88.4	0.985	-20.5
700	0.906	-46.9	2.660	1115.3	0.003	94.6	0.983	-23.7
800	0.887	-52.9	2.605	106.5	0.004	107.2	0.981	-26.8
900	0.868	-58.8	2.527	97.8	0.004	114.9	0.977	-30.0
1000	0.852	-64.3	2.457	89.6	0.004	129.7	0.9377	-33.1

Table 2 Noise data: V_{DS} = 9 V; V_{G2-S} = 4 V; I_D = 12 mA

f	F _{min} Γ _{opt}		R _n	
(MHz)	(dB)	(ratio)	(deg)	(Ω)
800	1.5	0.684	40.94	40.4

BF1109; BF1109R; BF1109WR

PACKAGE OUTLINES

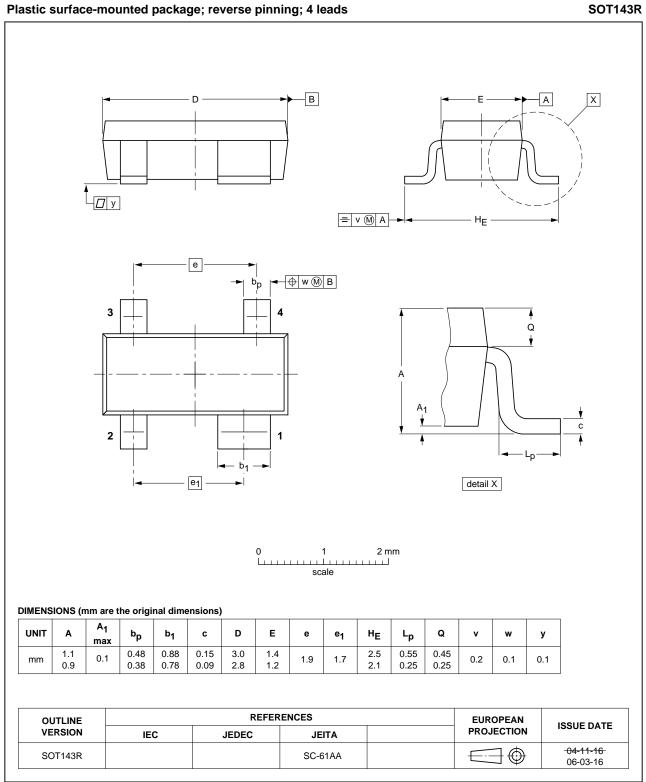


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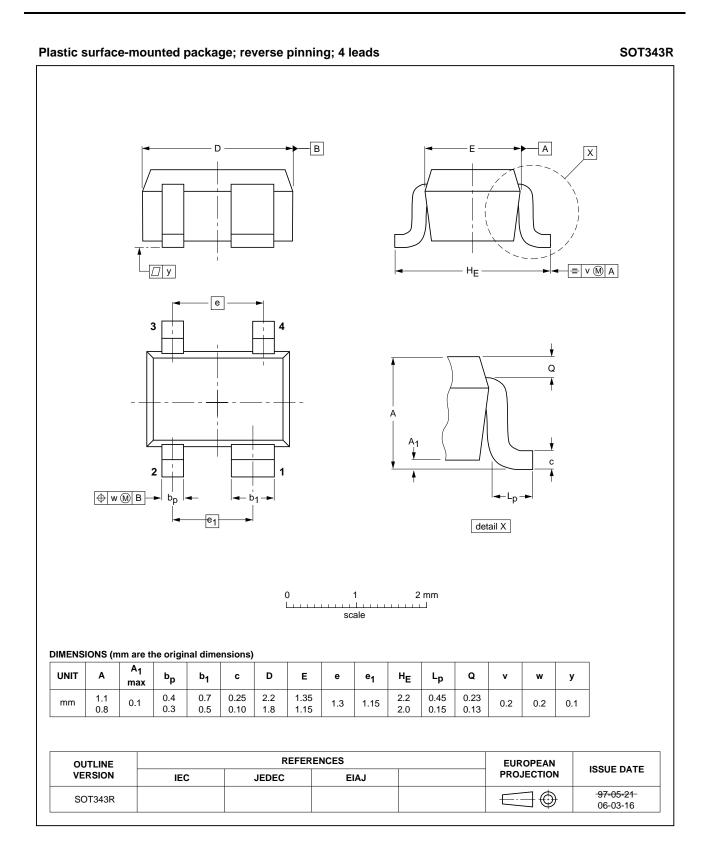
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SOT143B

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BF1109; BF1109R; BF1109WR



BF1109; BF1109R; BF1109WR

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Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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